

CE EMC Test Report

Project No. : 1908C156
Equipment : LCD Monitor
Brand Name : N/A
Test Model : **34G2*****(*=A-Z,a-z,0-9,/, +,-,\ or blank)
Series Model : N/A
Applicant : TPV Electronics (Fujian) Co., Ltd.
Address : Rongqiao Economic and Technological Development Zone, Fuqing City,
Fujian Province, P.R. China
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Test Sample : Engineering Sample No.: DG19082261
Standard(s) : EN 55032:2012+AC:2013
EN 55032:2015
EN 55032:2015+AC:2016
IEC 61000-3-2:2014 / EN 61000-3-2:2014
IEC 61000-3-3:2013 / EN 61000-3-3:2013
EN 55024:2010
EN 55024:2010+A1:2015

The above equipment has been tested and found compliance with the requirement of the relative standards by BTL Inc.

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Declaration

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BTL's laboratory quality assurance procedures are in compliance with the **ISO/IEC 17025** requirements, and accredited by the conformity assessment authorities listed in this test report.

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The information, data and test plan are provided by manufacturer which may affect the validity of results, so it is manufacturer's responsibility to ensure that the apparatus meets the essential requirements of applied standards and in all the possible configurations as representative of its intended use.

Limitation

For the use of the authority's logo is limited unless the Test Standard(s)/Scope(s)/Item(s) mentioned in this test report is (are) included in the conformity assessment authorities acceptance respective.

Please note that the measurement uncertainty is provided for informational purpose only and are not use in determining the Pass/Fail results.

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REPORT ISSUED HISTORY

Report Version	Description	Issued Date
R00	Original Issue.	Dec. 05, 2019

1. SUMMARY OF TEST RESULTS

Test procedures according to the technical standards:

Emission			
Standard(s)	Test Item	Result	
EN 55032:2012+AC:2013 EN 55032:2015 EN 55032:2015+AC:2016	Radiated emissions up to 1 GHz	PASS	
	Radiated emissions above 1 GHz	PASS	
	Radiated emissions from FM receivers	N/A	
	Conducted emissions AC mains power port	PASS	
	Asymmetric mode conducted emissions	AAN	N/A
		Current Probe	N/A
		CP+CVP	N/A
Conducted differential voltage emissions	N/A		

Standard(s)	Test Item	Result
IEC 61000-3-2:2014 EN 61000-3-2:2014	Harmonic current	PASS
IEC 61000-3-3:2013 EN 61000-3-3:2013	Voltage fluctuations (Flicker)	PASS

Immunity			
Standard(s)	Ref Standard(s)	Test Item	Result
EN 55024: 2010/ EN 55024:2010+A1:2015	IEC 61000-4-2:2008 / EN 61000-4-2:2009	ESD	PASS
	IEC 61000-4-3: 2006+A1:2007+A2:2010 / EN 61000-4-3: 2006+A1:2008+A2:2010	RS	PASS
	IEC 61000-4-4:2012 / EN 61000-4-4:2012	EFT	PASS
	IEC 61000-4-5: 2014+A1:2017 / EN 61000-4-5:2014+A1:2017	Surge	PASS
	IEC 61000-4-6:2013 / EN 61000-4-6:2014+AC:2015	CS	PASS
	IEC 61000-4-8:2009 / EN 61000-4-8:2010	PFMF	PASS
	IEC 61000-4-11: 2004+A1:2017 / EN 61000-4-11: 2004+A1:2017	Dip	PASS

NOTE:

- (1) "N/A" denotes test is not applicable to this device.